TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MH165FK

8-Bit Shift Register (P-In, S-Out)

The TC7MH165FK is an advanced high speed CMOS 8-bit parallel/serial-in, serial-out shift register fabricated with silicon gate C^2MOS technology.

It achieves the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

It consists of parallel-in or serial-in, serial-out 8-bit shift register with a gated clock input. When the SHIFT/LOAD input is held high, the serial data input is enabled and the eight flip-flops perform serial shifting with each clock pulse.

When the SHIFT/ $\overline{\text{LOAD}}$ input is held low, the parallel data is loaded synchronously into the register at positive going transition of the clock pulse.

VSSOP16-P-0030-0.50 Weight: 0.02 g (typ.)

The CK-INH input should be shifted high only when the CK input is held high.

An Input protection circuit ensures that 0 to 7 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and on two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

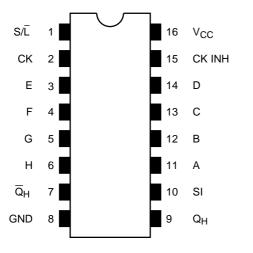
Features

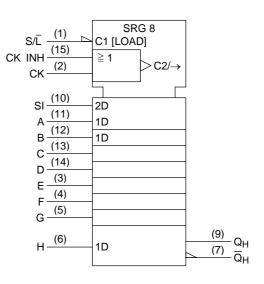
- High speed: $f_{max} = 150 \text{ MHz} (typ.) (V_{CC} = 5 \text{ V})$
- Low power dissipation: $ICC = 4 \mu A (max) (Ta = 25^{\circ}C)$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = 2~5.5 V
- Pin and function compatible with 74ALS165

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Pin Assignment (top view)

IEC Logic Symbol





Truth Table

		Inputs		Internal	Outputs	Outputs				
Shift/ LOAD	CK INH	СК	Serial In	Parallel AH	Q _A	Q _B	Q _H	\overline{Q}_H		
L	Х	Х	Х	ah	а	b	h	ĥ		
н	L		Н	Х	н	Q _{An}	Q _{Gn}	\overline{Q}_{Gn}		
н	L		L	Х	L	Q _{An}	Q _{Gn}	\overline{Q}_{Gn}		
н		L	Н	Х	Н	Q _{An}	Q _{Gn}	\overline{Q}_{Gn}		
н		L	L	Х	L	Q _{An}	Q _{Gn}	\overline{Q}_{Gn}		
н	Х	Н	Х	Х	No change					
н	Н	Х	Х	Х	No change					

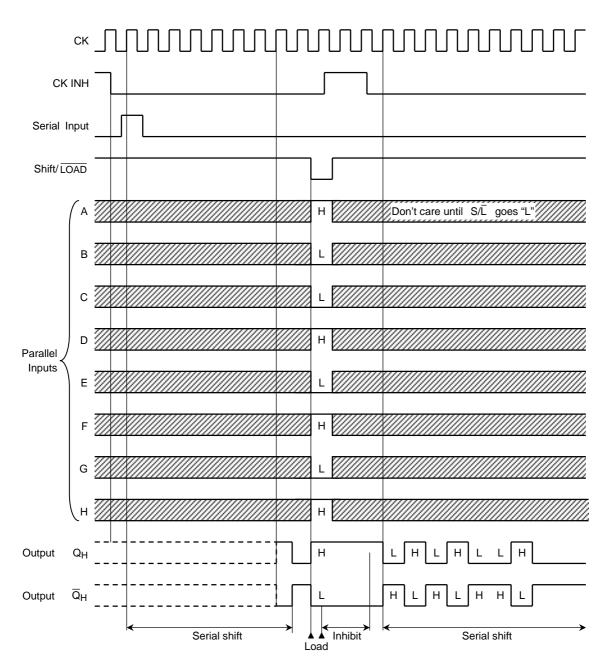
X: Don't care

a..... h: The level of steady state input voltage at inputs A through H respectively

 $Q_{An}-Q_{Gn}$: The level of $Q_A \sim Q_G$, respectively, before the most recent positive transition of the CK.

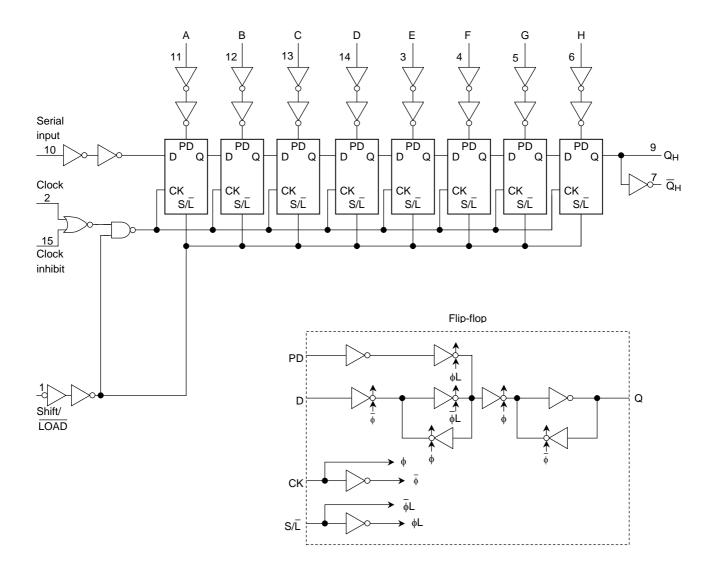
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Timing Chart



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System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5~7.0	V
DC input voltage	V _{IN}	-0.5~7.0	V
DC output voltage	V _{OUT}	$-0.5 \sim V_{CC} + 0.5$	V
Input diode current	IIK	-20	mA
Output diode current	I _{OK}	±20	mA
DC output current	IOUT	±25	mA
DC V _{CC} /ground current	ICC	±50	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	-65~150	°C

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0~5.5	V	
Input voltage	V _{IN}	0~5.5	V	
Output voltage	V _{OUT}	0~V _{CC}	V	
Operating temperature	T _{opr}	-40~85	°C	
Input rise and fall time	dt/dv	0~100 (V_{CC} = 3.3 \pm 0.3 V)	ns/V	
	u, uv	0~20 (V_{CC} = 5 \pm 0.5 V)	ns/V	

Electrical Characteristics

DC Characteristics

Characteristics S		Symbol	Toot	Test Condition		-	Ta = 25°0	2	Ta = -40~85°C		Unit
		Symbol	Test	Condition	$V_{CC}(V)$	Min	Тур.	Max	Min	Max	Unit
			_		2.0	1.50			1.50		V
	High level	VIH			3.0~5.5	$\begin{array}{c} V_{CC} \\ \times \ 0.7 \end{array}$	_		$\begin{array}{c} V_{CC} \\ \times \ 0.7 \end{array}$	_	
Input voltage					2.0			0.50		0.50	
	Low level	VIL		—			_	$V_{CC} \times 0.3$	_	$\begin{array}{c} V_{CC} \\ \times \ 0.3 \end{array}$	
	High level			I _{OH} = -50 μA	2.0	1.9	2.0	_	1.9	_	V
		V _{OH}	V _{IN} = V _{IH} or V _{IL}		3.0	2.9	3.0	_	2.9		
					4.5	4.4	4.5	_	4.4	_	
				$I_{OH} = -4 \text{ mA}$	3.0	2.58	_	_	2.48	_	
Output voltage				I _{OH} = -8 mA	4.5	3.94	_	_	3.80	Max — 0.50 V _{CC} × 0.3 — —	
Output voltage	Low level	Vol		I _{OL} = 50 μA	2.0	_	0	0.1	_	0.1	
					3.0		0	0.1	_	0.1	
			V _{IN} = V _{IH} or V _{IL}		4.5	_	0	0.1	_	0.1	
				$I_{OL} = 4 \text{ mA}$	3.0	_	—	0.36		0.44	
				I _{OL} = 8 mA	4.5	_	—	0.36		0.44	
Input leakage cu	Input leakage current		$V_{IN} = 5.5 \text{ V or GND}$		0~5.5	_	—	±0.1		±1.0	μA
Quiescent supply current		ICC	$V_{IN} = V_{CC}$ or GND		5.5			4.0	_	40.0	μA

Timing Requirements (Input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C	Unit	
Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Limit	Limit	Unit	
Minimum pulse width	t _{w (L)}		$\textbf{3.3}\pm\textbf{0.3}$		6.0	7.0	ns	
(CK, CK INH)	t _{w (H)}		5.0 ± 0.5	_	4.0	4.0	110	
Minimum pulse width	tu av		$\textbf{3.3}\pm\textbf{0.3}$		7.5	9.0	200	
(S/L)	t _{W (L)}		5.0 ± 0.5	_	5.0	6.0	ns	
Minimum set-up time	ts		$\textbf{3.3}\pm\textbf{0.3}$		7.5	8.5	20	
(A~H- S/L)	۲s		5.0 ± 0.5	_	5.0	5.0	ns	
Minimum set-up time	ts		$\textbf{3.3}\pm\textbf{0.3}$	_	5.0	6.0	ns	
(SI-CK, CK INH)	۲s		5.0 ± 0.5	_	4.0	4.0	115	
Minimum set-up time	ts		$\textbf{3.3}\pm\textbf{0.3}$	_	5.0	6.0	ns	
(S/L-CK, CK INH)	۲s		5.0 ± 0.5	_	4.0	4.0		
Minimum hold time	+.		$\textbf{3.3}\pm\textbf{0.3}$	_	0.5	0.5	ns	
(A~H- S/L)	t _h		5.0 ± 0.5	_	1.0	1.0	ns	
Minimum hold time	* .		$\textbf{3.3}\pm\textbf{0.3}$	_	0	0	20	
(SI-CK, CK INH)	t _h	—	5.0 ± 0.5	_	0.5	0.5	ns	
Minimum hold time	* .		$\textbf{3.3}\pm\textbf{0.3}$	_	0	0		
(S/L-CK, CK INH)	t _h	—	5.0 ± 0.5		0.5	0.5	ns	
Minimum removal time			$\textbf{3.3}\pm\textbf{0.3}$		5.0	5.0		
(CK INH-CK) (CK-CK INH)	t _{rem}	_	5.0 ± 0.5		3.5	3.5	ns	

AC Characteristics (Input: $t_r = t_f = 3 \text{ ns}$)

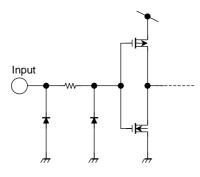
Characteristics	Question	Test Candition			Ta = 25°C)	Ta = -4	Ta = -40~85°C	
Characteristics	Symbol	Test Condition	V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	Unit
			3.3 ± 0.3	15		9.9	15.4	1.0	18.0	ns
Propagation delay time	t _{pLH}			50		12.4	18.9	1.0	21.5	
$(CK, CK INH-Q_H, \overline{Q}_H)$	t _{pHL}	_	5.0 ± 0.5	15		6.6	9.9	1.0	11.5	115
			5.0 ± 0.5	50		8.1	11.9	1.0	13.5	
			3.3 ± 0.3	15		9.9	15.8	1.0	18.5	
Propagation delay time	^t pLH ^t pHL	_	5.5 ± 0.5	50		12.4	19.3	1.0	22.0	ns
$(S/L-Q_H, \overline{Q}_H)$			5.0 ± 0.5	15		6.7	9.9	1.0	11.5	
				50		8.2	11.9	1.0	13.5	
	t _{pLH} t _{pHL}	_	3.3 ± 0.3	15		9.2	14.1	1.0	16.5	ns
Propagation delay time (H-Q _H , \overline{Q}_{H})			5.5 ± 0.5	50		11.7	17.6	1.0	20.0	
			5.0 ± 0.5	15		5.9	9.0	1.0	10.5	
			5.0 ± 0.5	50		7.4	11.0	1.011.51.013.51.018.51.022.01.011.51.013.51.016.51.020.0		
			3.3 ± 0.3	15	65	85	_	55	_	MHz
Maximum clock frequency	f _{max}	_	5.5 ± 0.5	50	60	105		50	_	
Maximum clock nequency			5.0 ± 0.5	15	110	150		90	_	
			5.0 ± 0.5	50	95	130		85		
Input capacitance	C _{IN}					4	10		10	pF
Power dissipation capacitance	C _{PD}			(Note)		50				pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

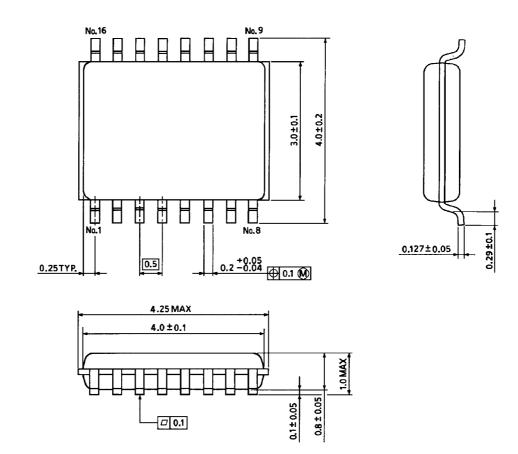
Input Equivalent Circuit



Package Dimensions

VSSOP16-P-0030-0.50

Unit : mm



Weight: 0.02 g (typ.)

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